


<b>Search Notes</b>  	<b>Application/Control No.</b>  10646416	<b>Applicant(s)/Patent Under Reexamination</b>  RACHMAN ET AL.
	<b>Examiner</b>  PHILIP WANG	<b>Art Unit</b>  2191

SEARCHED			
Class	Subclass	Date	Examiner
717	100	1/11/2010	pw
717	174-177	1/11/2010	pw

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(all databases)	12/2/2008	pw
EAST	7/28/2009	pw
EAST	7/27/2009	pw
EAST	1/11/2010	pw
EAST	1/5/2010	pw
EIC	1/6/2010	pw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
717	174-177	7/27/2009	pw
717	100	7/27/2009	pw
717	100	1/11/2010	pw
717	174-177	1/11/2010	pw

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